

<b>Notice of References Cited</b>	Application/Control No. 10/010,145	Applicant(s)/Patent Under Reexamination CAUTLEY ET AL.	
	Examiner Linda Krisciunas	Art Unit 3623	Page 1 of 1

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*	B	US-2005/0097016	05-2005	Barnard et al.	705/030
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